

## New England Biolabs Certificate of Analysis

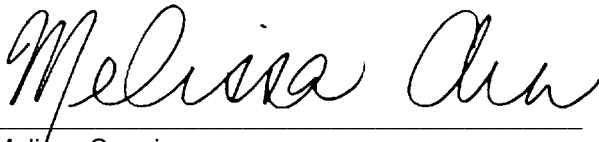
**Product Name:** NEBNext® End Repair Reaction Buffer  
**Catalog Number:** B6052S  
**Concentration:** 10 X Concentrate  
**Packaging Lot Number:** 10063990  
**Expiration Date:** 12/2021  
**Storage Temperature:** -20°C  
**Specification Version:** PS-B6052S v2.0  
**Composition (1X):** 50 mM Tris-HCl, 10 mM MgCl<sub>2</sub>, 10 mM DTT, 1 mM ATP, 0.4 mM dATP, 0.4 mM dCTP, 0.4 mM dGTP, 0.4 mM dTTP, (pH 7.5 @ 25°C)

NEBNext® End Repair Reaction Buffer Component List			
NEB Part Number	Component Description	Lot Number	Individual QC Result
B6052SVIAL	NEBNext® End Repair Reaction Buffer	10063991	Pass

Assay Name/Specification	Lot # 10063990
<b>Endonuclease Activity (Nicking, Buffer)</b> A 50 µl reaction in 1X NEBNext® End Repair Reaction Buffer containing 1 µg of supercoiled PhiX174 DNA incubated for 4 hours at 37°C results in <10% conversion to the nicked form as determined by agarose gel electrophoresis.	Pass
<b>Non-Specific DNase Activity (16 hour, Buffer)</b> A 50 µl reaction in 1X NEBNext® End Repair Reaction Buffer containing 1 µg of T3 or T7 DNA in addition to a reaction containing Lambda-HindIII DNA incubated for 16 hours at 37°C results in a DNA pattern free of detectable nuclease degradation as determined by agarose gel electrophoresis.	Pass
<b>Phosphatase Activity (pNPP, Buffer)</b> A 200 µl reaction in 1M Diethanolamine @ pH 9.8 and 0.5 mM MgCl <sub>2</sub> containing 2.5 mM p-Nitrophenyl Phosphate (pNPP) and a minimum of 20 µl NEBNext® End Repair Reaction Buffer incubated for 4 hours at 37°C yields <0.00001 unit of alkaline phosphatase activity as determined by spectrophotometric analysis.	Pass
<b>RNase Activity (Buffer)</b> A 10 µl reaction in 1X NEBNext® End Repair Reaction Buffer containing 40 ng of a 300 base single-stranded RNA is incubated at 37°C. After incubation for 16 hours, >90% of the substrate RNA remains intact as determined by gel electrophoresis using fluorescent detection.	Pass

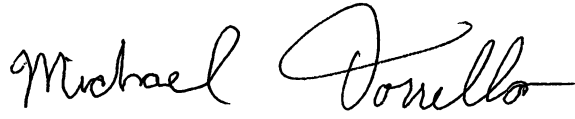
This product has been tested and shown to be in compliance with all specifications.

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Melissa Cormier  
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06 Mar 2020



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Michael Tonello  
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14 Dec 2020